Notice of References Cited Application/Control No. 10/611,923 Examiner Prabodh M. Dharia Applicant(s)/Patent Under Reexamination YONENO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0182435 A1	09-2003	Redlich et al.	709/229
*	В	US-6,323,846 B1	11-2001	Westerman et al.	345/173
*	С	US-6,421,453 B1	07-2002	Kanevsky et al.	382/115
*	Đ	US-6,466,198 B1	10-2002	Feinstein, David Y.	345/158
*	E	US-6,304,638 B1	10-2001	Coulter et al.	379/93.37
*	F	US-6,331,848 B1	12-2001	Stove et al.	345/156
*	G	US-2002/0125324 A1	09-2002	Yavid et al.	235/462.45
*	Н	US-2003/0167908 A1	09-2003	Nishitani et al.	84/723
	i	US-			
	J	US-			
	К	US-			
	۲	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					3
	T					

NON-PATENT DOCUMENTS

_							
L	*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
		υ					
		V					
		w					
		x					

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.